

Design, Analysis, Simulation, and Applications of 741 Op-Amps as a Signal Converter Circuits on Different Environmental Conditions

Thesis
Submitted for Ph. D. Degree in Philosophy of Science
(Physics)

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2007



كلية البنات للأداب و العلوم و التربية قسم الفيزياء

دراسة تصميم و تحليل و تطبيق مكبرات العمليات في الدوائر الرقمية في ظروف بيئة تشغيل مختلفة

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المدرس المساعد بقسم الفيزياء كلية البنات ـ جامعة عين شمس

(الفيزياء)

. / هدى عبد المنعم عشرى أستاذ الفيزياء الإشعاعية بالمركز القومي لبحوث و تكنولوجيا الإشعاع

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/ مدرس الإلكترونيات بقسم الفيزياء كلية البنات جامعة عين شمس / عائشة مصطفى سويدان أستاذ الإلكترونيات بقسم الفيزياء كلية البنات جامعة عين شمس

كلية البنات للعلوم والآداب والتربية جامعة عين شمس

2007

بسم الله الرحمن الرحيم

(ميكما مياحا حبن كان المتملذ الما إله ملذ لا كانميس)

(حدق الله العظيم)

الآية (35) سورة البغره.

Acknowledgements

First, I would like to thank *ALLAH* said that; "any work without good definite purpose is a scattered cinder". Our main purpose for this work is seeking *ALLAH* pleasing and satisfaction".

The author would like to thank *Prof. Dr. Amera Dakrory* the head of Physics Department for her continuos encouragement and extraordinary help.

Also, the author wishes to express her gratitude, to *Prof. H. A. Ashry*, Chairman of Radiation Research branch, National Center for Radiation Research & Technology, *Prof. Dr. Eng. Fouad Abd-El Moniem Saad Soliman*, Vice President, Exploration Sector, Nuclear Materials Authority, *Dr Aisha Mostafa Swidan*, Prof. of Electronics, Physics Department, Women's College, Ain Shams University and *Dr. Safaa Mohamed Raushidy El-Ghanam*, Lecturer of Electronics, Physics Department, Women's College, Ain Shams University for their capable supervision, fruitful guidance throughout the course of the work, and their continuos encouragement.

Also, many thanks for all members of Physics Department for kind cooperation.

Finally, I would like to thank my family for continuous encouragement and patience.

Abstract

The present thesis is devoted on studying the effect of the different environmental conditions (heat and radiation) on the electrical parameters of the four sets of 741 operational amplifiers (op-amps). The samples are chosen with different manufacturing techniques, they are: µA741 CN (Fairchild), LM741 CN (National Semiconductor), and HA17741 OK & HA17741 1D1 (Hitachi). The main investigated electrical parameters are input offset voltage, input bias current, input offset current, closed loop gain, common-mode rejection ratio, input impedance, output impedance and slew rate. Besides, the study is extended to include some applications for such commonly used amplifiers on the field of digital- and signal conversion- circuits; digital-to-analog, analog-to-digital converters, integrator, differentiator and Schmitt trigger. In this concern, the design and analysis of the different investigated circuits were carried out experimentally, where the obtained results were compared with those obtained either by applying a special Electronic Workbench Software Package or from mathematical models solved by computer programming using C++ language.

The effect of the circuit elements on the operation of the proposed signal conversion circuits (Integrator, Differentiator and Schmitt trigger) is considered experimentally, where the obtained results are shown to be in close agreement with the simulation- and theoretical- results.

The study is extended to include the effect of temperature (up to around 75 °C) on the electrical parameters of the different operational amplifiers and the operation of the proposed signal conversion circuits.

The obtained results were compared with those of the simulation, where an excellent agreement was achieved.

As the op-amps are widely used in many electronic instrumentation which can be exposed to different types of radiation, so, the present study can be considered as a trial to shed further light on the effect of gamma radiation on the physical and electrical properties of the proposed operational amplifiers. As well as on the operation of the investigated signal conversion circuits. It is clearly shown that a pronounced change occurs on the electrical characteristics of the op-amps., and consequently the devices may lose their main features. The input offset voltage, input offset current, and input bias current are shown to increase with increasing gamma dose. Also, the closed loop gain of the op-amps. are shown to decrease with increasing gamma dose, where its decreasing rate is considered as a function of the operating frequency value. As a result, the slew rate, common-mode rejection ratio and input impedance were shown to decrease with increasing gamma dose levels. On the other hand, and as the output impedance is inversely proportional to the gain; so, its value increases with increasing gamma exposure. Finally, it is clearly shown that the radiation dependence of the op-amp electrical parameters is a function of the fabrication technique of the op-amps, where, the opamps of the types HA17741 1D1 and HA17741 OK are shown to be less sensitive to gamma rays exposure than the op-amps of the types LM741 CN and µA741 CN.

Also, the behavior of signal conversion circuits was studied under the effect of gamma rays dose levels (from 0 up to 20 kGy). The transfer functions of binary weighted resistor DAC and R-2R ladder DAC lose their linearity, due to gamma exposure. On the other hand, there is a decrease in the output voltage of the ladder R-2R DAC circuit under the influence of gamma ray. While the radiation slightly affected the transfer function of flash analog-to-digital converter.

In the integrator and differentiator circuits, the dc voltage increases with increasing the input offset voltage of operational amplifiers. This input offset voltage increases with increasing radiation doses, so, the output waveforms of both circuits the maximum-and-minimum-edges are shifted upward. On the other hand, the gain of these circuits was independent on gamma doses from the low frequency up to around 40 kHz, but in higher frequencies the gain decreases. Also, the results show that, the maximum and minimum edges at different gamma doses of integrator and differentiator were dependent on frequency values in all op-amps.

Finally, in the Schmitt trigger circuit, the lower threshold voltage level (LTL) increases with increasing the offset voltage, which increases with increasing γ -dose levels.

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List of Symbols and Abbreviations

Op-Amp Operational amplifier

DAC Digital-to-analog converter

ADC Analog-to-digital converter

V_{io} Input offset voltage

I_B Input bias current

Input offset current

Z_{in} Input impedance

Z_{out} Output impedance

A_o Open-loop voltage gain

SR Slew rate

CMRR Common-Mode Rejection Ratio

GBW Gain bandwidth product

 f_T Unity gain bandwidth

 A_C Closed loop gain

s Feedback ratio

 A_o S Loop gain

A_d Differential gain

A_{cm} Common-mode gain

dB Decibel

LSB Least-significant bit
MSB Most-significant bit

DNL Differential non linearity

INL Integral non linearity

Maximum The maximum amplitude, typically the most positive

peak voltage

Minimum The minimum amplitude, typically the most negative

peak voltage.

LTL Lower trigger level

UTL Upper trigger level